

Notice of References Cited

Application/Control No.

10/828,629

Applicant(s)/Patent Under
Reexamination
LEE ET AL.

Examiner

SEAN MOTSINGER

Art Unit

2624

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,912,165	06-1999	Cabib et al.	435/287.2
	B	US-			
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	D	US-			
	E	US-			
	F	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	"A curvature based multi-resolution automatic karyotyping system" Garcia , Cristina, et al Departamento Tecnologia Electronica ETSI telecomunicacion Universidad de Malaga Published online 3 June 2003
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	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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